

### FEATURES

- High Thermal Cycling Capability
- Soft Punch Through Silicon
- Isolated MMC Base with AlN Substrates

### APPLICATIONS

- High Reliability Inverters
- Motor Controllers
- Traction Auxiliaries

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 600V to 6500V and currents up to 2400A.

The DIM400XSM65-K000 is a single switch 6500V, n channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA). This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

### ORDERING INFORMATION

Order As:

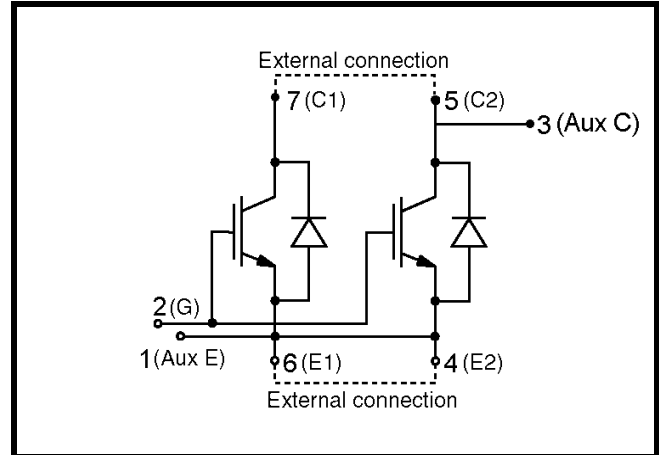
**DIM400XSM65-K000**

Note: When ordering, please use the complete part number

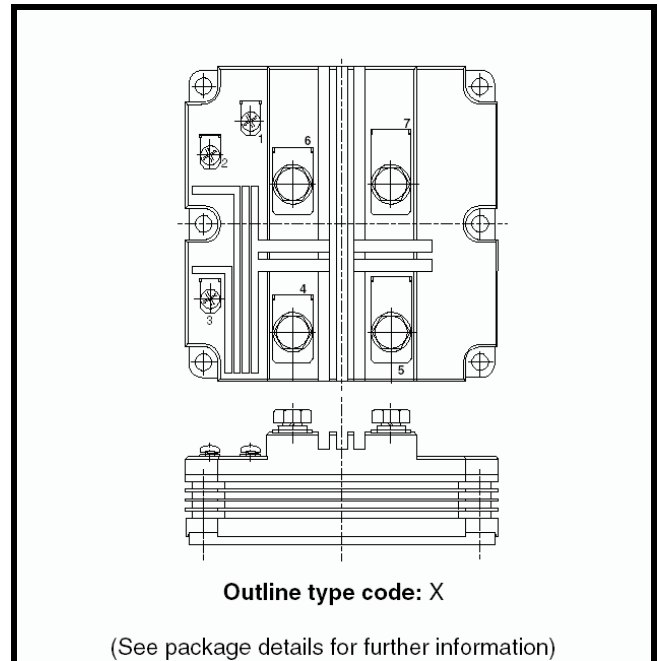
### KEY PARAMETERS

$V_{CES}$		<b>6500V</b>
$V_{CE(sat)}^*$	<b>(typ)</b>	<b>4.0V</b>
$I_C$	<b>(max)</b>	<b>400A</b>
$I_{C(PK)}$	<b>(max)</b>	<b>800A</b>

\* (measured at the power busbars and not the auxiliary terminals)



**Fig. 1 Single switch circuit diagram**



**Fig. 2 Electrical connections - (not to scale)**

## ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

$T_{case} = 25^{\circ}\text{C}$  unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
$V_{CES}$	Collector-emitter voltage	$V_{GE} = 0V, T_{VJ} = -40^{\circ}\text{C}$	5800	V
		$V_{GE} = 0V$	6300	V
		$V_{GE} = 0V, T_{VJ} = 125^{\circ}\text{C}$	6500	V
$V_{GES}$	Gate-emitter voltage		$\pm 20$	V
$I_C$	Continuous collector current	$T_{case} = 90^{\circ}\text{C}$	400	A
$I_{C(PK)}$	Peak collector current	1ms, $T_{case} = 115^{\circ}\text{C}$	800	A
$P_{max}$	Maximum transistor power dissipation	$T_{case} = 25^{\circ}\text{C}, T_j = 150^{\circ}\text{C}$	8.3	kW
$I^2t$	Diode $I^2t$ value (Diode arm)	$V_R = 0, t_p = 10\text{ms}, T_{vj} = 125^{\circ}\text{C}$	97	$\text{kA}^2\text{s}$
$V_{isol}$	Isolation voltage-per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	10.2	kV
$Q_{PD}$	Partial discharge-per module	IEC1287. $V_1 = 6900V, V_2 = 5100V, 50\text{Hz RMS}$	10	pC

**THERMAL AND MECHANICAL RATINGS**

Internal insulation material:     AlN  
 Baseplate material:                 AlSiC  
 Creepage distance:                 56mm  
 Clearance:                             26mm  
 CTI (Critical Tracking Index):     >600

Symbol	Parameter	Test Conditions	Min	Typ.	Max	Units
$R_{th(j-c)}$	Thermal resistance -transistor (per switch)	Continuous dissipation - junction to case		-	15	°C/kW
$R_{th(j-c)}$	Thermal resistance -diode (per switch)	Continuous dissipation - junction to case		-	30	°C/kW
$R_{th(c-h)}$	Thermal resistance -case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)		-	8	°C/kW
$T_j$	Junction temperature	Transistor	-	-	125	°C
		Diode	-	-	125	°C
$T_{stg}$	Storage temperature range	-	-40	-	125	°C
	Screw torque	Mounting M6	-	-	5	Nm
		Electrical connections - M4	-	-	2	Nm
		Electrical connections - M8	-	-	10	Nm

## ELECTRICAL CHARACTERISTICS

$T_{case} = 25^{\circ}\text{C}$  unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
$I_{CES}$	Collector cut-off current	$V_{GE} = 0\text{V}, V_{CE} = V_{CES}$			3	mA
		$V_{GE} = 0\text{V}, V_{CE} = V_{CES},$ $T_{case} = 125^{\circ}\text{C}$			60	mA
$I_{GES}$	Gate leakage current	$V_{GE} = 20\text{V}, V_{CE} = 0\text{V}$			8	$\mu\text{A}$
$V_{GE(TH)}$	Gate threshold voltage	$I_C = 80\text{mA}, V_{GE} = V_{CE}$	5.5	6.5	7.5	V
$V_{CE(sat)\dagger}$	Collector-emitter saturation voltage	$V_{GE} = 15\text{V}, I_C = 400\text{A}$		4.0		V
		$V_{GE} = 15\text{V}, I_C = 400\text{A},,$ $T_{VJ} = 125^{\circ}\text{C}$		5.6		V
$I_F$	Diode forward current	DC			400	A
$I_{FM}$	Diode maximum forward current	$t_p = 1\text{ms}$			800	A
$V_F$	Diode forward voltage	$I_F = 400\text{A}$		3.6		V
		$I_F = 400\text{A}, T_{VJ} = 125^{\circ}\text{C}$		4.1		V
$C_{ies}$	Input capacitance	$V_{CE} = 25\text{V}, V_{GE} = 0\text{V},$ $f = 1\text{MHz}$		120		nF
$C_{res}$	Reverse transfer capacitance	$V_{CE} = 25\text{V}, V_{GE} = 0\text{V},$ $f = 1\text{MHz}$		1.5		nF
$L_M$	Module inductance			20		nH
$R_{INT}$	Internal transistor resistance			0.18		$\text{m}\Omega$

### Note:

<sup>†</sup> Measured at the power busbars and not the auxiliary terminals

**ELECTRICAL CHARACTERISTICS**
**T<sub>case</sub> = 25° C unless stated otherwise**

Symbol	Parameter	Test Conditions	Min	Typ.	Max	Units	
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> =400A V <sub>GE</sub> =±15V V <sub>CE</sub> =3600V R <sub>G(ON)</sub> =6.2Ω R <sub>G(OFF)</sub> =18Ω C <sub>ge</sub> =44nF L ~200nH		6.0		us	
t <sub>f</sub>	Fall time			250		ns	
E <sub>OFF</sub>	Turn-off energy loss				1450		mJ
t <sub>d(on)</sub>	Turn-on delay time				900		ns
t <sub>r</sub>	Rise time				250		ns
E <sub>ON</sub>	Turn-on energy loss				3000		mJ
Q <sub>g</sub>	Gate charge				8		uC
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> =400A, V <sub>CE</sub> =3600V, di <sub>F</sub> /dt =1300A/us		700		uC	
I <sub>rr</sub>	Diode reverse recovery current			300		A	
E <sub>rec</sub>	Diode reverse recovery energy				1300		mJ

**T<sub>case</sub> = 125° C unless stated otherwise**

Symbol	Parameter	Test Conditions	Min	Typ.	Max	Units	
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> =400A V <sub>GE</sub> =±15V V <sub>CE</sub> =3600V R <sub>G(ON)</sub> =6.2Ω R <sub>G(OFF)</sub> =18Ω C <sub>ge</sub> =44nF L ~200nH		6.0		us	
t <sub>f</sub>	Fall time			250		ns	
E <sub>OFF</sub>	Turn-off energy loss				1750		mJ
t <sub>d(on)</sub>	Turn-on delay time				700		ns
t <sub>r</sub>	Rise time				200		ns
E <sub>ON</sub>	Turn-on energy loss				3500		mJ
Q <sub>rr</sub>	Diode reverse recovery charge		I <sub>F</sub> =400A, V <sub>CE</sub> =3600V, di <sub>F</sub> /dt =1600A/us		1000		uC
I <sub>rr</sub>	Diode reverse recovery current			370		A	
E <sub>rec</sub>	Diode reverse recovery energy				2000		mJ

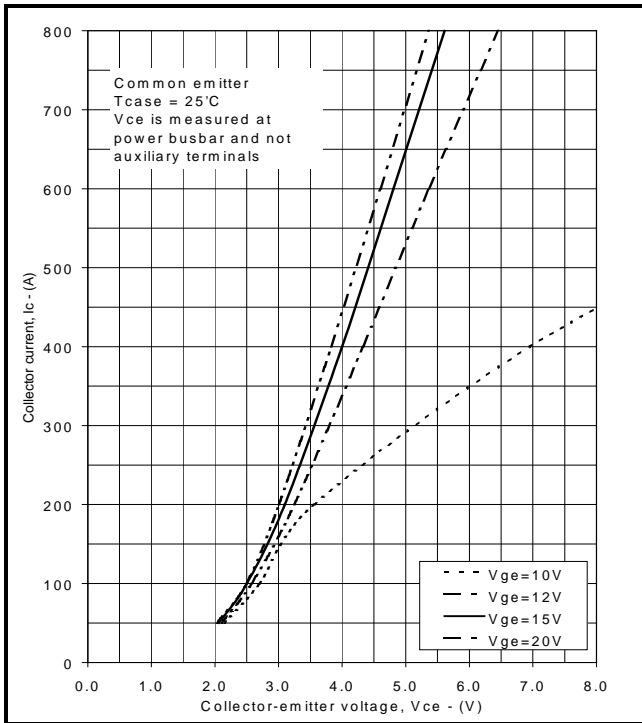


Fig.3 Typical output characteristics

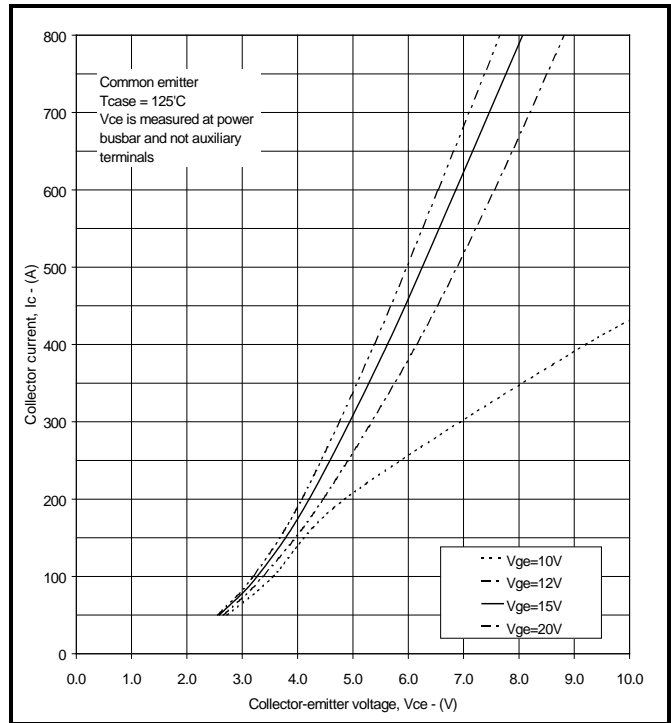


Fig.4 Typical output characteristics

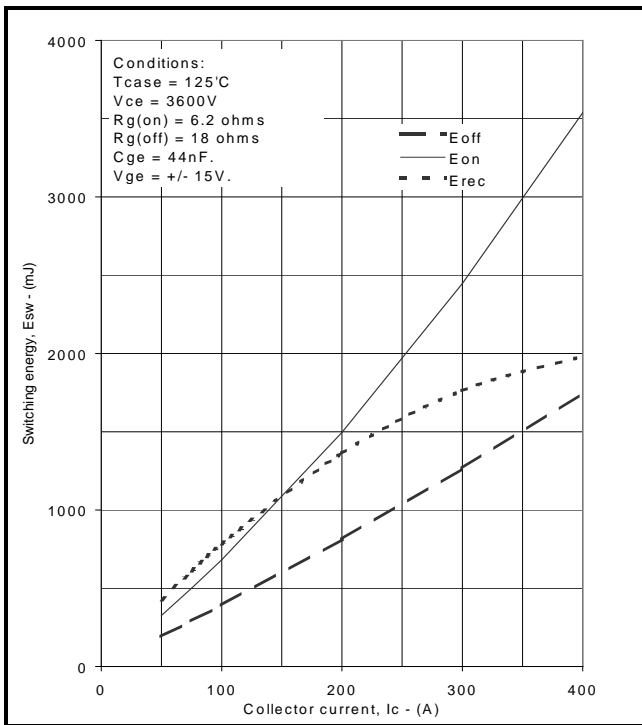


Fig.5 Typical switching energy vs collector current

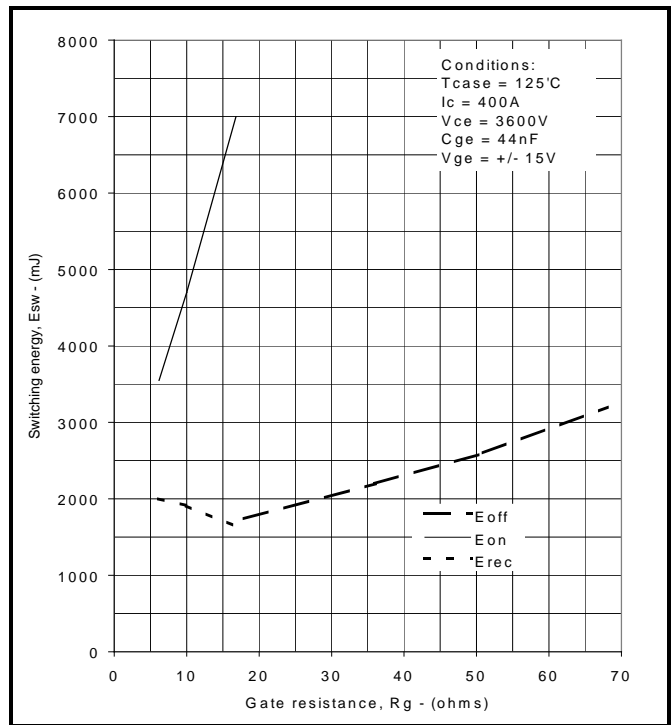
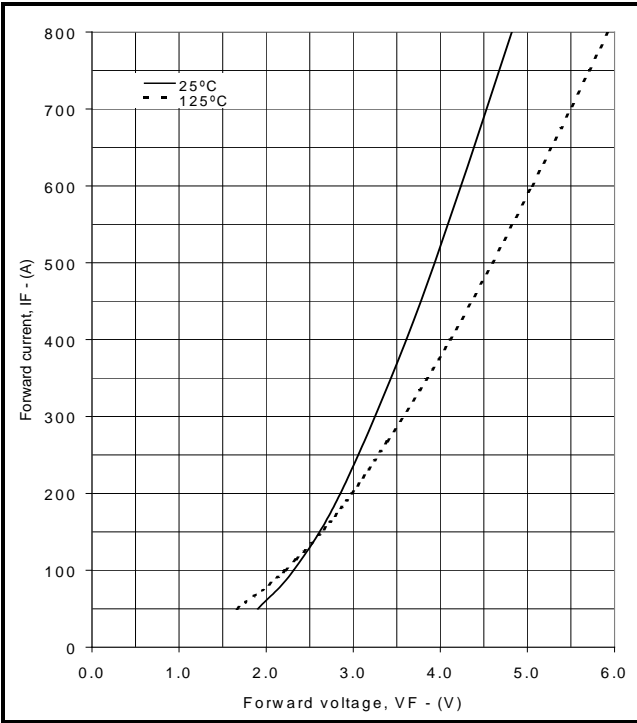
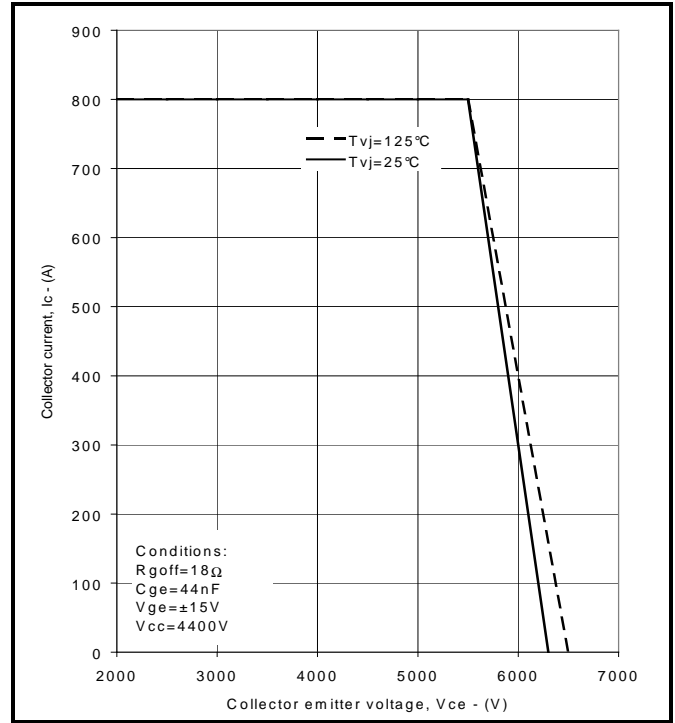


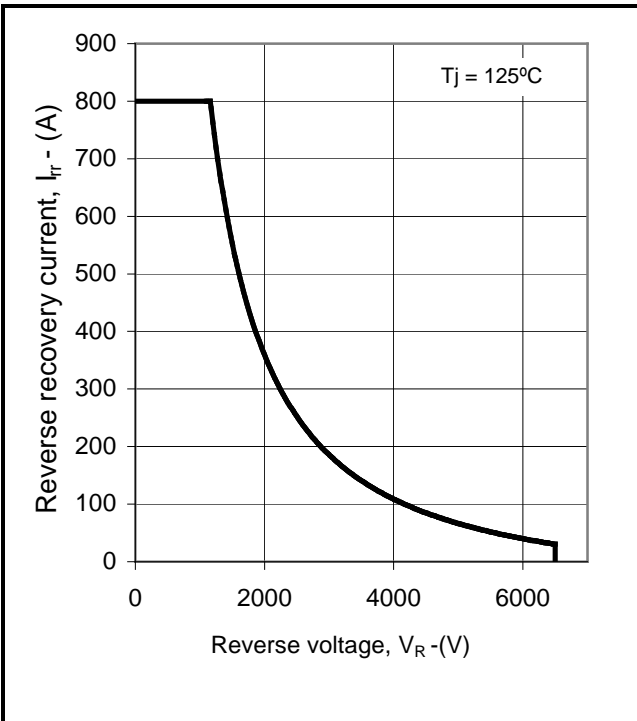
Fig.6 Typical switching energy vs gate resistance



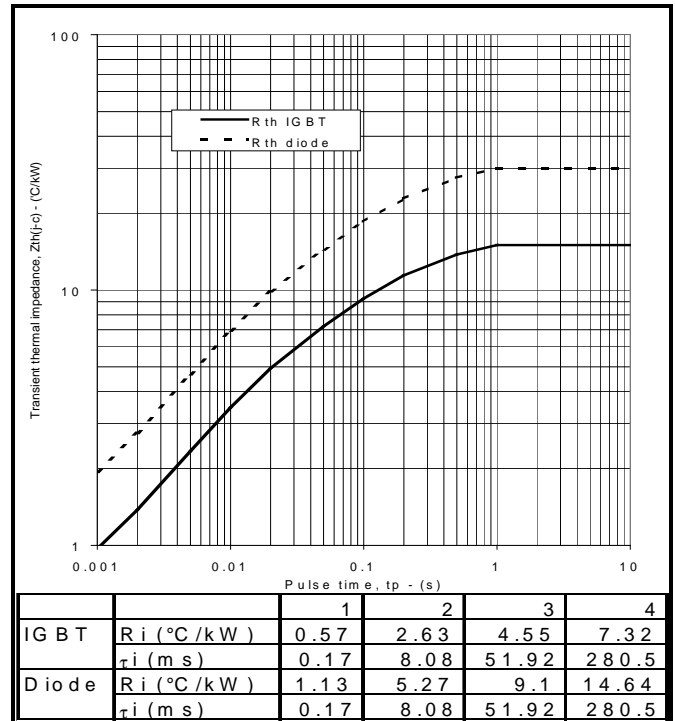
**Fig.7 Diode typical forward characteristics**



**Fig.8 Reverse bias safe operating area**



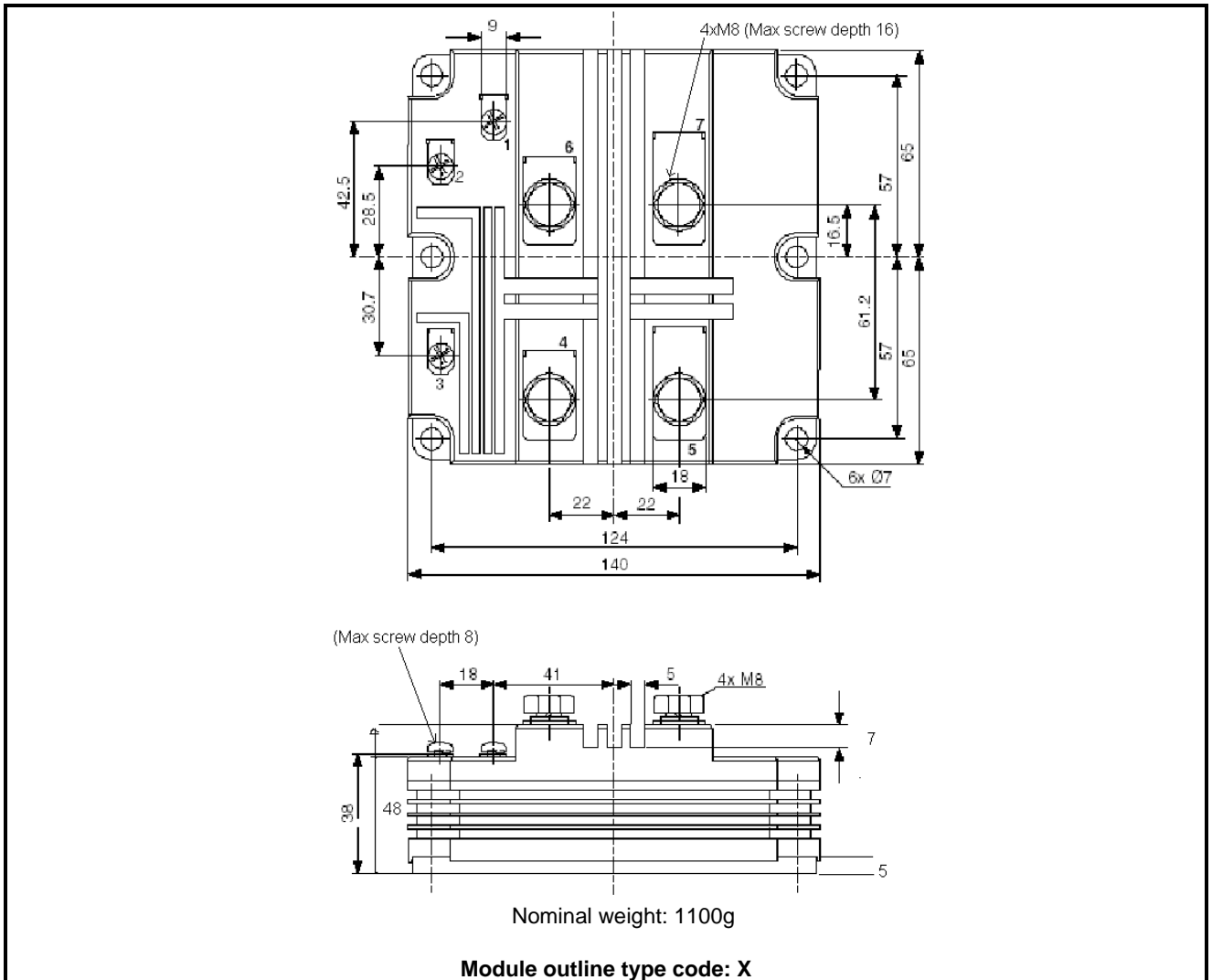
**Fig.9 Diode reverse bias safe operating area**



**Fig.10 Transient thermal impedance**

**PACKAGE DETAILS**

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise.  
DO NOT SCALE.





## POWER ASSEMBLY CAPABILITY

The Power Assembly group was set up to provide a support service for those customers requiring more than the basic semiconductor, and has developed a flexible range of heatsink and clamping systems in line with advances in device voltages and current capability of our semiconductors.

We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group offers high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers.

Using the latest CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete Solution (PACs).

## HEATSINKS

The Power Assembly group has its own proprietary range of extruded aluminium heatsinks which have been designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or Customer Services.



<http://www.dynexsemi.com>

e-mail: [power\\_solutions@dynexsemi.com](mailto:power_solutions@dynexsemi.com)

### HEADQUARTERS OPERATIONS

**DYNEX SEMICONDUCTOR LTD**  
Doddington Road, Lincoln  
Lincolnshire, LN6 3LF. United Kingdom.  
Tel: +44(0)1522 500500  
Fax: +44(0)1522 500550

### CUSTOMER SERVICE

Tel: +44(0)1522 502753 / 502901. Fax: +44(0)1522 500020

© Dynex Semiconductor 2003 TECHNICAL DOCUMENTATION – NOT FOR RESALE. PRODUCED IN UNITED KINGDOM.

#### Datasheet Annotations:

Dynex Semiconductor annotate datasheets in the top right hand corner of the front page, to indicate product status. The annotations are as follows:-

**Target Information:** This is the most tentative form of information and represents a very preliminary specification. No actual design work on the product has been started.

**Preliminary Information:** The product is in design and development. The datasheet represents the product as it is understood but details may change.

**Advance Information:** The product design is complete and final characterisation for volume production is well in hand.

**No Annotation:** The product parameters are fixed and the product is available to datasheet specification.

This publication is issued to provide information only which (unless agreed by the Company in writing) may not be used, applied or reproduced for any purpose nor form part of any order or contract nor to be regarded as a representation relating to the products or services concerned. No warranty or guarantee express or implied is made regarding the capability, performance or suitability of any product or service. The Company reserves the right to alter without prior notice the specification, design or price of any product or service. Information concerning possible methods of use is provided as a guide only and does not constitute any guarantee that such methods of use will be satisfactory in a specific piece of equipment. It is the user's responsibility to fully determine the performance and suitability of any equipment using such information and to ensure that any publication or data used is up to date and has not been superseded. These products are not suitable for use in any medical products whose failure to perform may result in significant injury or death to the user. All products and materials are sold and services provided subject to the Company's conditions of sale, which are available on request.

All brand names and product names used in this publication are trademarks, registered trademarks or trade names of their respective owners.